FAIRCHILD

SEMICONDUCTOR®

SSP7N60B/SSS7N60B

600V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supplies.

Features

- 7.0A, 600V, $R_{DS(on)} = 1.2\Omega @V_{GS} = 10 V$ Low gate charge (typical 38 nC)
- Low Crss (typical 23 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- TO-220F package isolation = 4.0kV (Note 6)



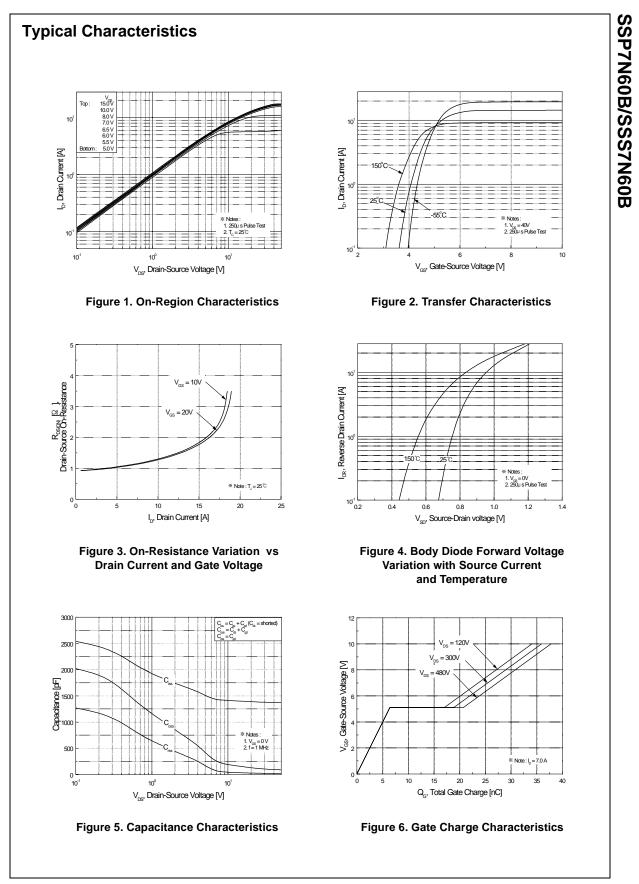
Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		SSP7N60B	SSS7N60B	Units
V _{DSS}	Drain-Source Voltage		6	00	V
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$)		7.0	7.0 *	А
	- Continuous ($T_C = 100^{\circ}C$)		4.4	4.4 *	А
I _{DM}	Drain Current - Pulsed	(Note 1)	28	28 *	А
V _{GSS}	SS Gate-Source Voltage		± 30		V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	420		mJ
I _{AR}	Avalanche Current	(Note 1)	7.0		А
E _{AR}	Repetitive Avalanche Energy (Note 1)		14.7		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		5.5		V/ns
P _D	Power Dissipation (T _C = 25°C) - Derate above 25°C		147	48	W
			1.18	0.38	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300		°C
'L					

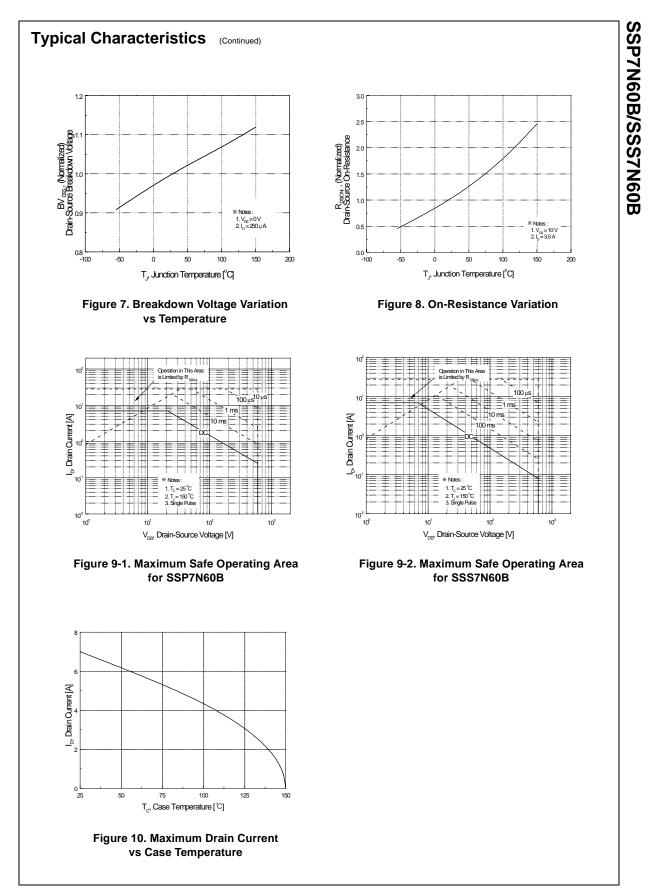
Thermal Characteristics

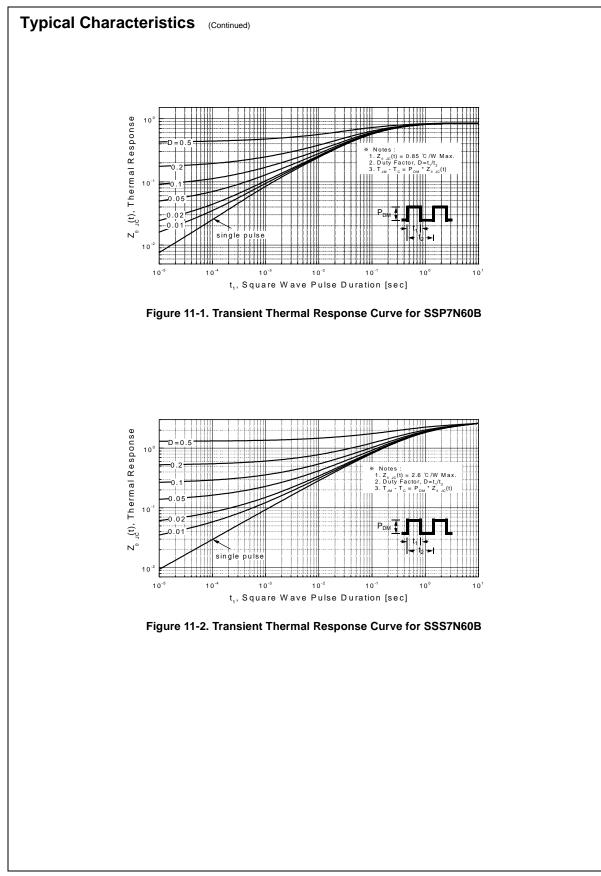
Symbol	Parameter	SSP7N60B	SSS7N60B	Units
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case Max.	0.85	2.6	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5		°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient Max.	62.5	62.5	°C/W

Parameter	Test Conditions	Min	Тур	Max	Units
racteristics					
Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	600			V
Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu$ A, Referenced to 25°C		0.65		V/°C
	V _{DS} = 600 V, V _{GS} = 0 V			10	μA
Zero Gate Voltage Drain Current	V _{DS} = 480 V, T _C = 125°C			100	μΑ
Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
actoristics					
	$V_{22} = V_{22}$ $I_2 = 250 \mu A$	2.0		10	V
•		2.0		4.0	v
On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.5 \text{ A}$		1.0	1.2	Ω
Forward Transconductance	V _{DS} = 40 V, I _D = 3.5 A (Note 4)		8.2		S
	l	1			
c Characteristics	1			r	
Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		1380	1800	pF
	f = 1.0 MHz		115	150	pF
Reverse Transfer Capacitance			23	30	pF
ng Characteristics	Γ		00	70	
	V _{DD} = 300 V, I _D = 7.0 A,				ns
	$R_G = 25 \Omega$				ns
	(Note 4 E)				ns
					ns nC
	_				nC
°					nC
	(1000,7)		10		no
ource Diode Characteristics ar	nd Maximum Ratings				
Maximum Continuous Drain-Source Dic	ode Forward Current			7.0	Α
				28	А
Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 7.0 A$			1.4	V
Reverse Recovery Time	$V_{GS} = 0 V, I_{S} = 7.0 A,$		415		ns
Reverse Recovery Charge	dI _F / dt = 100 A/µs (Note 4)		4.6		μC
	Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse acteristics Gate Threshold Voltage Static Drain-Source On-Resistance Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics ar Maximum Continuous Drain-Source Diode F	Coefficient $I_D = 250 \ \mu\text{A}$, Referenced to 25 CZero Gate Voltage Drain Current $V_{DS} = 600 \ V, V_{GS} = 0 \ V$ Gate-Body Leakage Current, Forward $V_{GS} = 30 \ V, V_{DS} = 0 \ V$ Gate-Body Leakage Current, Reverse $V_{GS} = -30 \ V, V_{DS} = 0 \ V$ acteristicsGate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \ \mu\text{A}$ Static Drain-Source $V_{GS} = 10 \ V, I_D = 3.5 \ A$ (Note 4)Forward Transconductance $V_{DS} = 40 \ V, I_D = 3.5 \ A$ (Note 4)E Characteristics $V_{DS} = 25 \ V, V_{GS} = 0 \ V, I_D = 3.5 \ A$ (Note 4)Input Capacitance $V_{DS} = 25 \ V, V_{GS} = 0 \ V, I_D = 3.5 \ A$ (Note 4)Porture Capacitance $V_{DS} = 25 \ V, V_{GS} = 0 \ V, I_D = 3.00 \ V, I_D = 3.00 \ V, I_D = 7.0 \ A, R_G = 25 \ \Omega$ Turn-On Delay Time $V_{DS} = 480 \ V, I_D = 7.0 \ A, R_G = 25 \ \Omega$ Turn-Off Delay Time $V_{DS} = 480 \ V, I_D = 7.0 \ A, V_{GS} = 10 \ V$ Turn-Off Fall Time(Note 4, 5)Total Gate Charge $V_{DS} = 480 \ V, I_D = 7.0 \ A, V_{GS} = 10 \ V$ Gate-Drain Charge $V_{DS} = 480 \ V, I_D = 7.0 \ A, V_{GS} = 10 \ V$ Maximum Continuous Drain-Source Diode Forward CurrentMaximum Continuous Drain-Source Diode Forward CurrentMaximum Pulsed Drain-Source Diode Forward CurrentMaximum Pulsed Drain-Source Diode Forward Current	Coefficient $I_D = 250 \ \mu\text{A}$, Referenced to $25 \ \text{C}$ Zero Gate Voltage Drain Current $V_{DS} = 600 \ \text{V}, V_{GS} = 0 \ \text{V}$ $V_{DS} = 480 \ \text{V}, T_C = 125^{\circ}\text{C}$ Gate-Body Leakage Current, Forward $V_{GS} = 30 \ \text{V}, V_{DS} = 0 \ \text{V}$ acteristics $V_{GS} = -30 \ \text{V}, V_{DS} = 0 \ \text{V}$ acteristics $V_{GS} = -30 \ \text{V}, V_{DS} = 0 \ \text{V}$ acteristics $V_{GS} = 10 \ \text{V}, I_D = 3.5 \ \text{A}$ On-Resistance $V_{DS} = 40 \ \text{V}, I_D = 3.5 \ \text{A}$ Forward Transconductance $V_{DS} = 25 \ \text{V}, V_{GS} = 0 \ \text{V},$ characteristicsInput Capacitance $V_{DS} = 25 \ \text{V}, V_{GS} = 0 \ \text{V},$ gCharacteristicsrTurn-On Delay Time $V_{DS} = 300 \ \text{V}, I_D = 7.0 \ \text{A},$ Turn-Off Delay Time $V_{DS} = 480 \ \text{V}, I_D = 7.0 \ \text{A},$ Turn-Off Fall Time $(Note 4, 5)$ Total Gate Charge $V_{DS} = 480 \ \text{V}, I_D = 7.0 \ \text{A},$ Gate-Source Charge $V_{DS} = 480 \ \text{V}, I_D = 7.0 \ \text{A},$ Gate-Source Charge $V_{DS} = 10 \ \text{V}$ murce Diode Characteristics and Maximum RatingsMaximum Continuous Drain-Source Diode Forward CurrentMaximum Pulsed Drain-Source Diode Forward Current	CoefficientID250 µA, Reterenced to 25 C0.65Zero Gate Voltage Drain Current $V_{DS} = 600 V, V_{GS} = 0 V$ $V_{DS} = 480 V, T_C = 125^{\circ}C$ Gate-Body Leakage Current, Forward $V_{GS} = 30 V, V_{DS} = 0 V$ Gate-Body Leakage Current, Reverse $V_{GS} = -30 V, V_{DS} = 0 V$ Gate-Body Leakage Current, Reverse $V_{GS} = -30 V, V_{DS} = 0 V$ acteristicsGate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \mu A$ 2.0Static Drain-Source $V_{GS} = 10 V, I_D = 3.5 A$ 1.0On-Resistance $V_{DS} = 40 V, I_D = 3.5 A$ 1.0Forward Transconductance $V_{DS} = 25 V, V_{GS} = 0 V,$ 8.2CharacteristicsInput Capacitance $V_{DS} = 25 V, V_{GS} = 0 V,$ 115Reverse Transfer Capacitance $f = 1.0 MHz$ 115Turn-On Delay Time $V_{DD} = 300 V, I_D = 7.0 A,$ 80Turn-Off Delay Time $V_{DS} = 480 V, I_D = 7.0 A,$ 86Turn-Off Fall Time $(Note 4, 5)$ 85Total Gate Charge $V_{DS} = 480 V, I_D = 7.0 A,$ 38Gate-Source Charge $V_{DS} = 10 V$ 15Durce Diode Characteristics and Maximum RatingsMaximum Continuous Drain-Source Diode Forward CurrentTuru-Maximum Pulsed Drain-Source Diode Forward Current	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

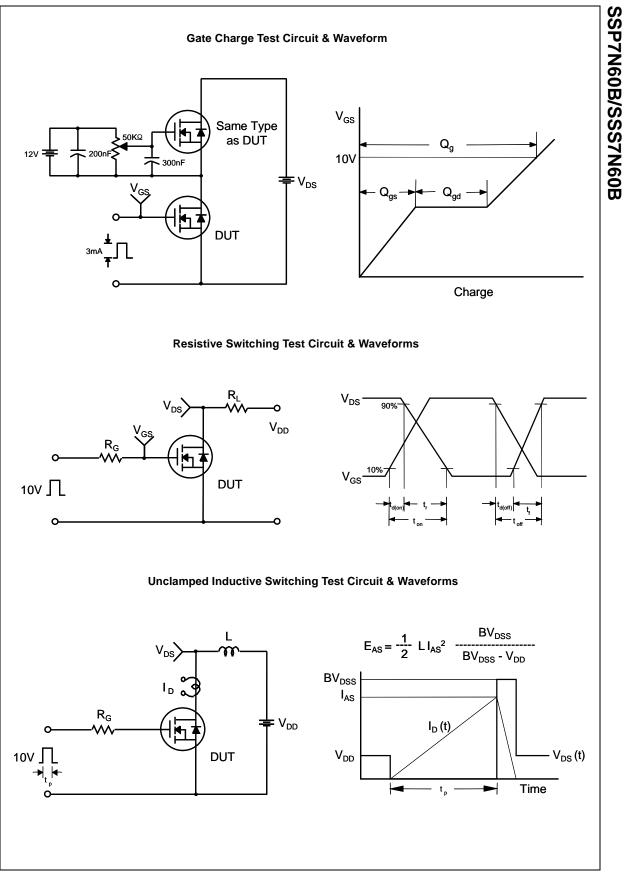


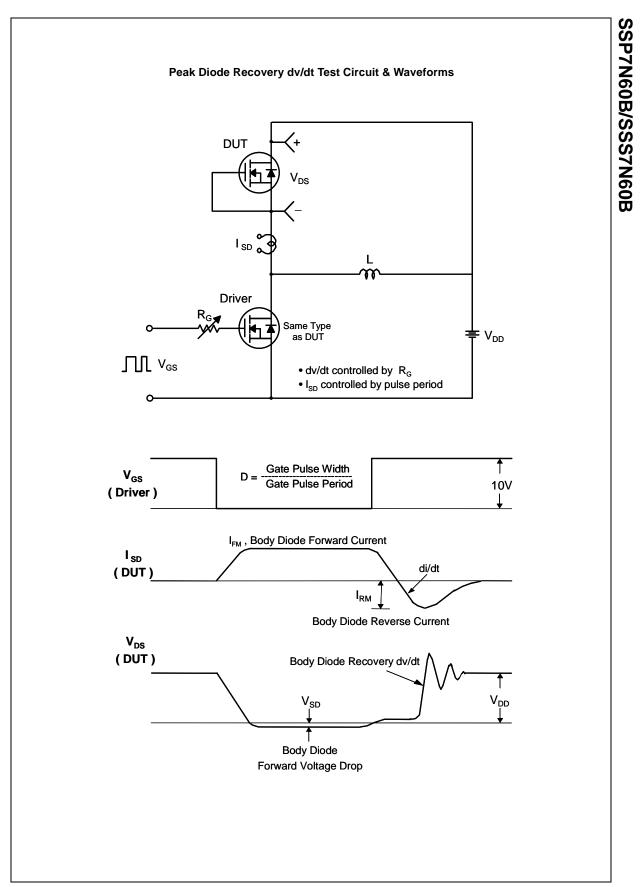
Rev. B, June 2002

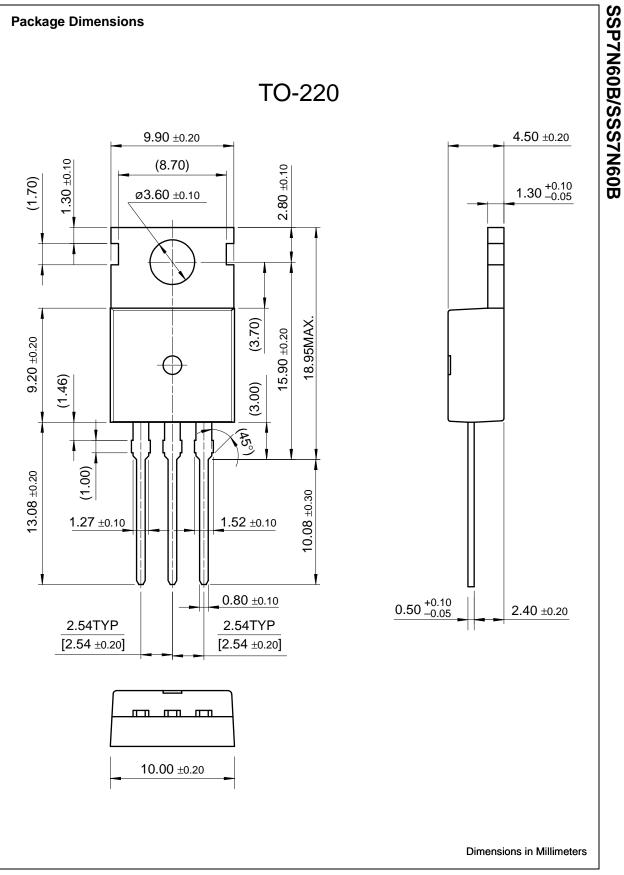


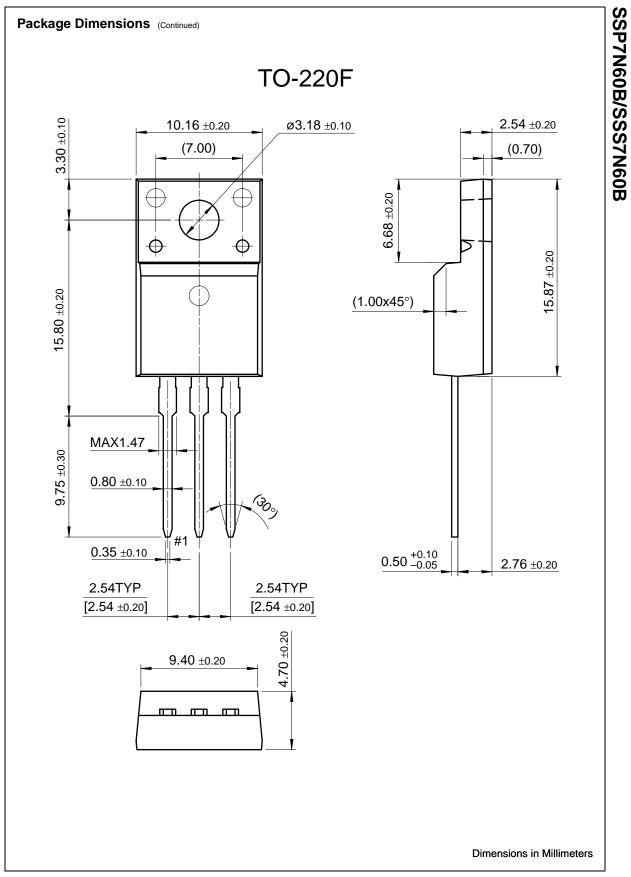


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